

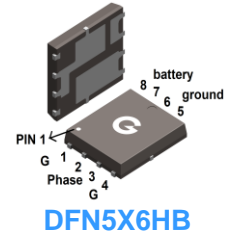
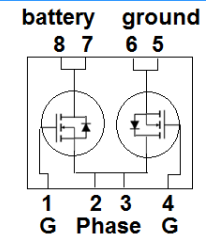
### Features

- Half-Bridge
- N-channel Enhancement mode
- High current capacity
- RoHS compliant with Halogen-free
- Qualified to AEC-Q101 Standards

HF

### Mechanical Data

- Case: DFN5X6HB
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208



### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
TBLS04NL050H	DFN5X6HB	5000 pcs / Tape & Reel	04NL050H

### Maximum Ratings (@ T<sub>C</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	40	V
Gate-to-Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current (T <sub>C</sub> = 25°C)	I <sub>D</sub>	78	A
Continuous Drain Current (T <sub>C</sub> = 100°C)		55	
Continuous Drain Current (T <sub>A</sub> = 25°C) *1		20	
Continuous Drain Current (T <sub>A</sub> = 100°C) *1		14	
Pulsed Drain Current (t <sub>p</sub> = 10μs, T <sub>C</sub> = 25°C)	I <sub>DM</sub>	312	A
Single Pulse Avalanche Energy (L = 0.5mH)	E <sub>AS</sub>	65	mJ
Single Pulse Avalanche Energy (L = 0.1mH) *3		40	
Power Dissipation (T <sub>C</sub> = 25°C)	P <sub>D</sub>	54	W
Power Dissipation (T <sub>A</sub> = 25°C) *1		3.8	
Operating Junction Temperature Range	T <sub>J</sub>	-55 ~ +175	°C
Storage Temperature Range	T <sub>STG</sub>	-55 ~ +175	°C

### Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case	R <sub>θJC</sub>	-	-	2.8	°C/W
Thermal Resistance Junction-to-Air *1	R <sub>θJA</sub>	-	-	40	°C/W

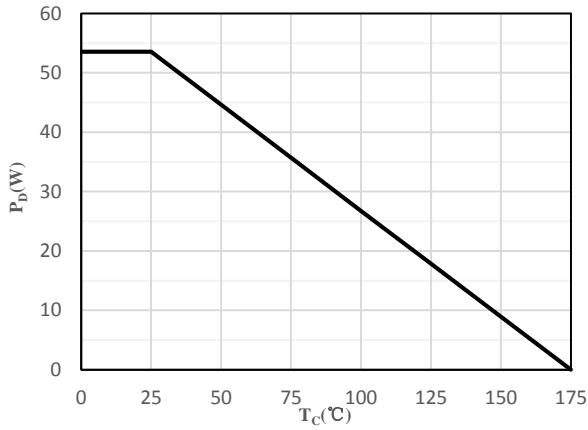
### Electrical Characteristics (@ T<sub>A</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
V <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	40	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 32V, V <sub>GS</sub> = 0V	-	-	1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	-	-	±100	nA
<b>On Characteristics</b>						
R <sub>DS(ON)</sub>	Drain-Source On-resistance *2	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A	-	4.2	5.0	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.4	1.9	2.5	V
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 0V, f = 1MHz	-	3.7	-	Ω
<b>Dynamic Characteristics</b>						
C <sub>ISS</sub>	Input Capacitance	V <sub>GS</sub> = 0V	-	1220	-	pF
C <sub>OSS</sub>	Output Capacitance	V <sub>DS</sub> = 20V	-	450	-	
C <sub>RSS</sub>	Reverse Transfer Capacitance	f = 300kHz	-	25	-	
<b>Switching Characteristics</b>						
t <sub>d(ON)</sub>	Turn-on Delay Time *4	V <sub>DD</sub> = 20V	-	7	-	ns
t <sub>r</sub>	Turn-on Rise Time *4	V <sub>GS</sub> = 10V	-	48	-	
t <sub>d(OFF)</sub>	Turn-Off Delay Time *4	I <sub>D</sub> = 20A	-	30	-	
t <sub>f</sub>	Turn-Off Fall Time *4	R <sub>G</sub> = 5Ω	-	12	-	
Q <sub>G</sub>	Total Gate-Charge	V <sub>DD</sub> = 20V	-	19.2	-	nC
Q <sub>GS</sub>	Gate to Source Charge	V <sub>GS</sub> = 10V	-	4	-	
Q <sub>GD</sub>	Gate to Drain (Miller) Charge	I <sub>D</sub> = 20A	-	3.5	-	
<b>Source-Drain Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage *2	I <sub>S</sub> = 20A, V <sub>GS</sub> = 0V	-	0.83	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> = 20A, V <sub>GS</sub> = 0V	-	57	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt = 100A/μs	-	45	-	nC

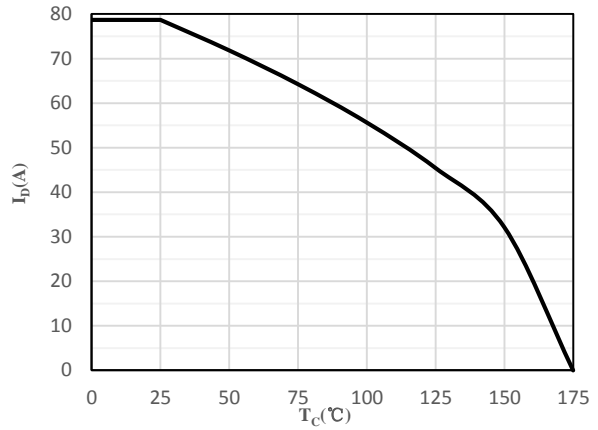
Notes:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper
2. The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
3. The E<sub>AS</sub> data shows Max. rating. The test condition is V<sub>DD</sub> = 20V, V<sub>GS</sub> = 10V, L = 0.1mH
4. Guaranteed by design, not subject to production

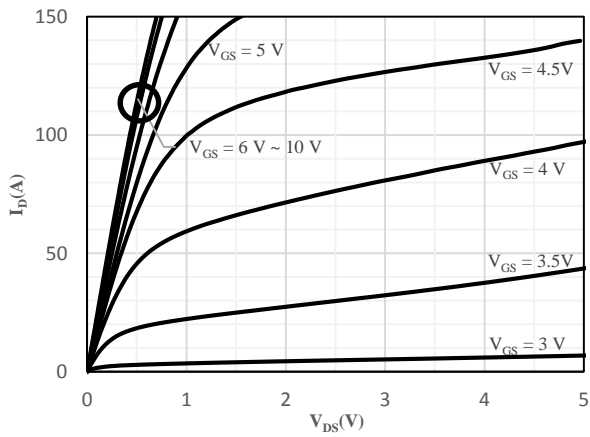
**Ratings and Characteristics Curves** (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)



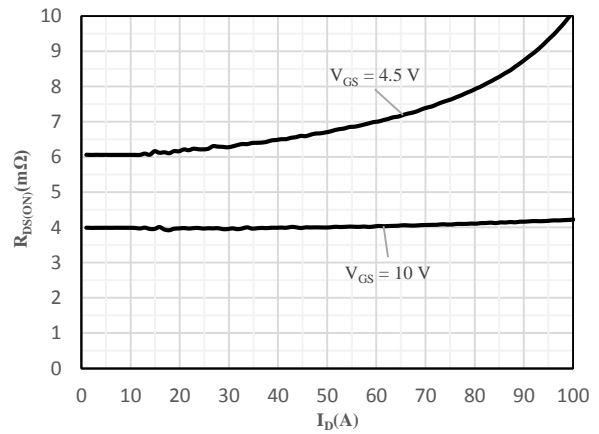
**Fig 1 Power Dissipation**



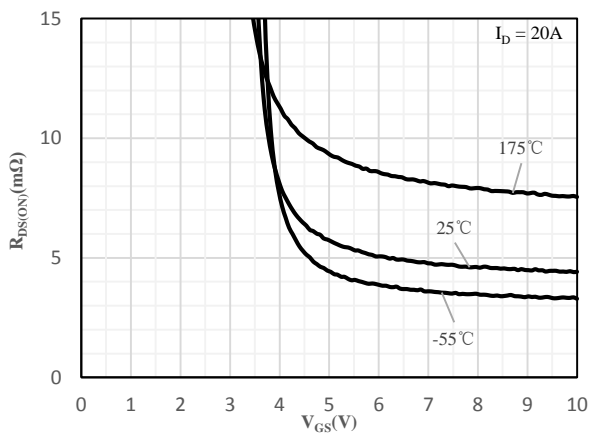
**Fig 2 Drain Current**



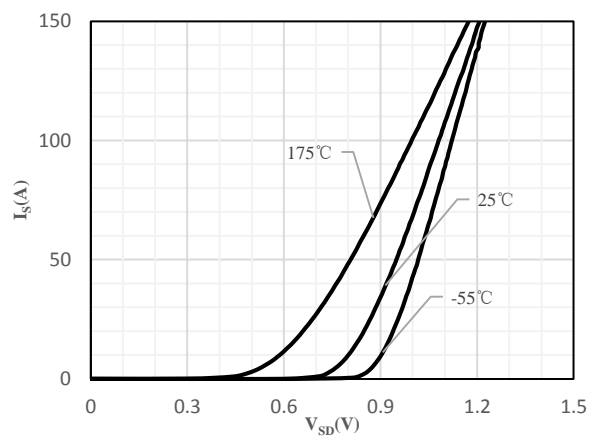
**Fig 3 Typical Output Characteristics**



**Fig 4 On-Resistance vs. Drain Current and Gate Voltage**



**Fig 5 On-Resistance vs. Gate-Source Voltage**



**Fig 6 Body-Diode Characteristics**

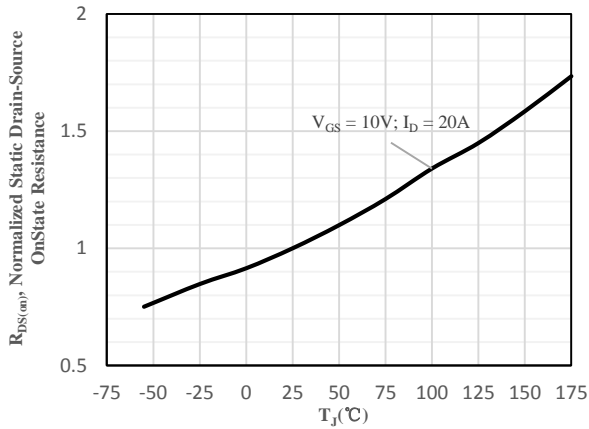


Fig 7 Normalized On-Resistance vs. Junction Temperature

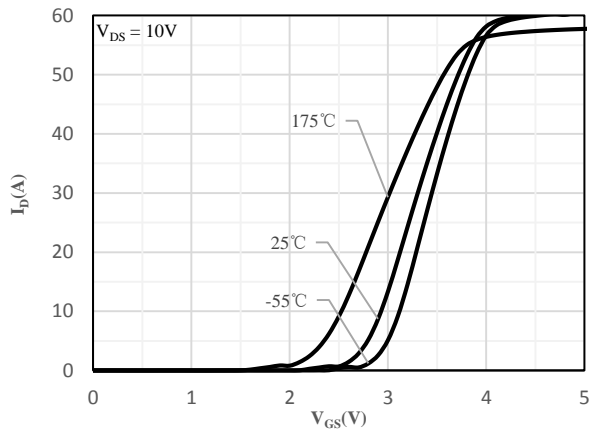


Fig 8 Transfer Characteristics

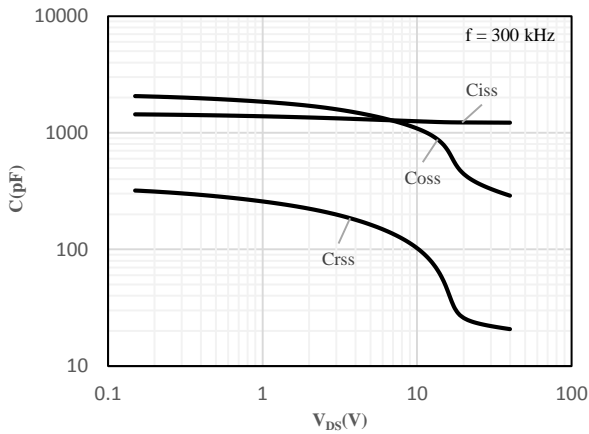


Fig 9 Capacitance Characteristics

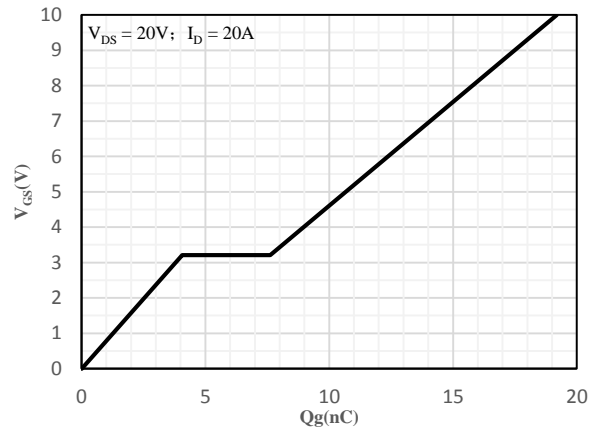


Fig 10 Gate-Charge Characteristics

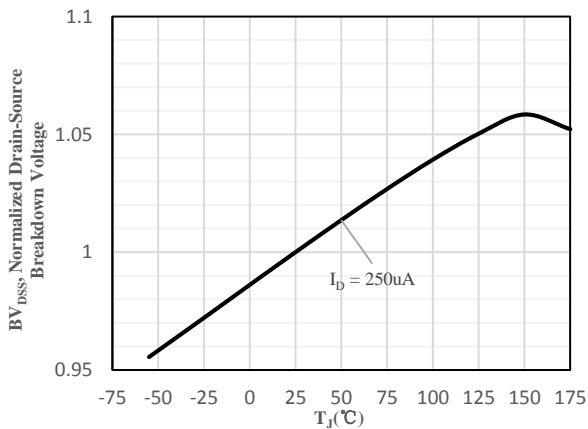


Fig 11 Normalized Breakdown Voltage vs. Junction Temperature

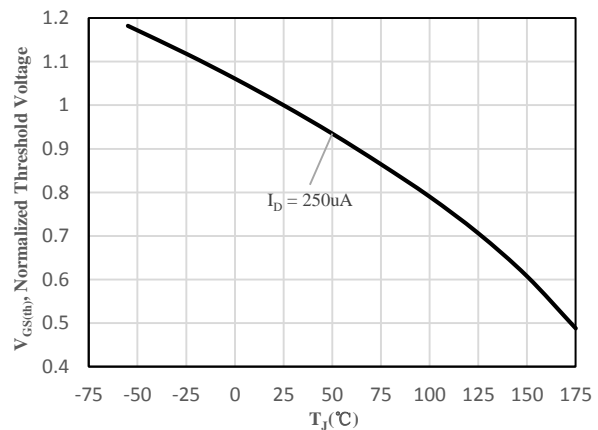
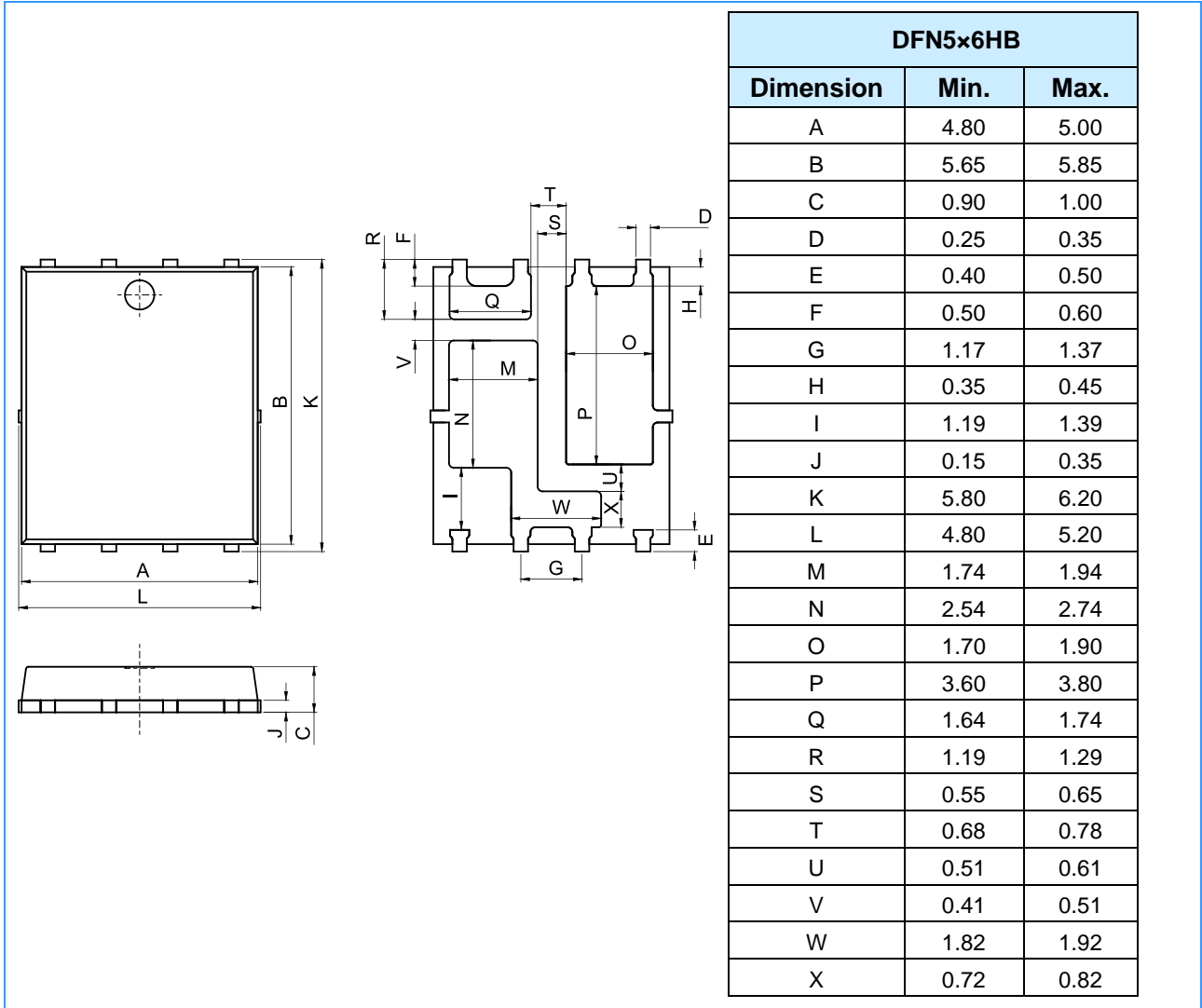


Fig 12 Normalized  $V_{GS(th)}$  vs. Junction Temperature

### Package Outline Dimensions (Unit: mm)



### Mounting Pad Layout (Unit: mm)

